## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination HUKARI ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,586,102 B1	07-2003	Stachowiak, Grzegorz	428/432
*	В	US-6,589,658 B1	07-2003	Stachowiak, Grzegorz	428/469
*	С	US-6,830,817 B2	12-2004	Stachowiak, Grzegorz	428/698
*	D	US-6,530,668 B2	03-2003	Krisko, Annette J.	359/883
*	E	US-6,495,251 B1	12-2002	Arbab et al.	428/336
*	F	US-6,472,072 B1	10-2002	Ebisawa et al.	359/585
	G	US-			
	Ι	US-			
	_	US-			
	7	US-			
	К	US-			
	L	US-		·	
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	q					
	R					
	S			_		
	Т		,			

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	·
	٧	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.